

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination IWATA ET AL.	
		Examiner	Art Unit	Page 1 of 1
U.S. PATENT DOCUMENTS				

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 2000105943 A	04-2000	Japan	TERAGAKI, YASUKO	
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NON-PATENT DOCUMENTS

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